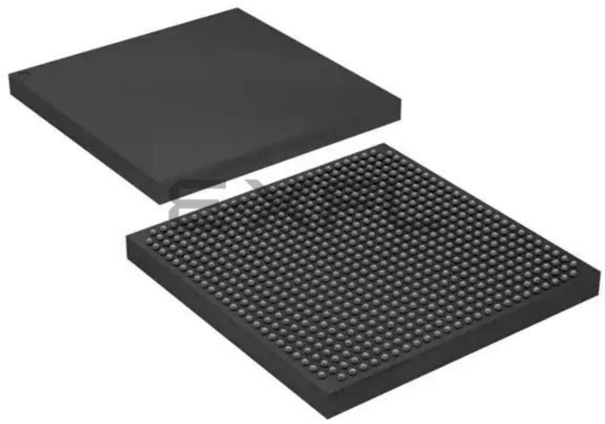

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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	2566
Number of Logic Elements/Cells	25660
Total RAM Bits	1944576
Number of I/O	455
Number of Gates	-
Voltage - Supply	1.425V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	672-BBGA
Supplier Device Package	672-FBGA (27x27)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep1sgx25df672c6

Table 1–1. Stratix GX Device Features

Feature	EP1SGX10C EP1SGX10D	EP1SGX25C EP1SGX25D EP1SGX25F	EP1SGX40D EP1SGX40G
LEs	10,570	25,660	41,250
Transceiver channels	4, 8	4, 8, 16	8, 20
Source-synchronous channels	22	39	45
M512 RAM blocks (32 × 18 bits)	94	224	384
M4K RAM blocks (128 × 36 bits)	60	138	183
M-RAM blocks (4K ×144 bits)	1	2	4
Total RAM bits	920,448	1,944,576	3,423,744
Digital signal processing (DSP) blocks	6	10	14
Embedded multipliers *(1)*	48	80	112
PLLs	4	4	8

Note to Table 1–1:

(1) This parameter lists the total number of 9- × 9-bit multipliers for each device. For the total number of 18- × 18-bit multipliers per device, divide the total number of 9- × 9-bit multipliers by 2. For the total number of 36- × 36-bit multipliers per device, decide the total number of 9- × 9-bit multipliers by 8.

Stratix GX devices are available in space-saving FineLine BGA® packages (refer to Tables 1–2 and 1–3), and in multiple speed grades (refer to Table 1–4). Stratix GX devices support vertical migration within the same package (that is, you can migrate between the EP1SGX10C and EP1SGX25C devices in the 672-pin FineLine BGA package). See the Stratix GX device pin tables for more information. Vertical migration means that you can migrate to devices whose dedicated pins, configuration pins, and power pins are the same for a given package across device densities. For I/O pin migration across densities, you must cross-reference the available I/O pins using the device pin-outs for all planned densities of a given package type, to identify which I/O pins it is possible to migrate. The Quartus II software can automatically cross reference and place all pins for migration when given a device migration list.

Table 1–2. Stratix GX Package Options & I/O Pin Counts (Part 1 of 2) Note (1)

Device	672-Pin FineLine BGA	1,020-Pin FineLine BGA
EP1SGX10C	362	
EP1SGX10D	362	
EP1SGX25C	455	

Table 1–2. Stratix GX Package Options & I/O Pin Counts (Part 2 of 2) Note (1)

Device	672-Pin FineLine BGA	1,020-Pin FineLine BGA
EP1SGX25D	455	607
EP1SGX25F		607
EP1SGX40D		624
EP1SGX40G		624

Note to Table 1–2:

(1) The number of I/O pins listed for each package includes dedicated clock pins and dedicated fast I/O pins. However, these numbers do not include high-speed or clock reference pins for high-speed I/O standards.

Table 1–3. Stratix GX FineLine BGA Package Sizes

Dimension	672 Pin	1,020 Pin
Pitch (mm)	1.00	1.00
Area (mm^2)	729	1,089
Length × width (mm × mm)	27 × 27	33 × 33

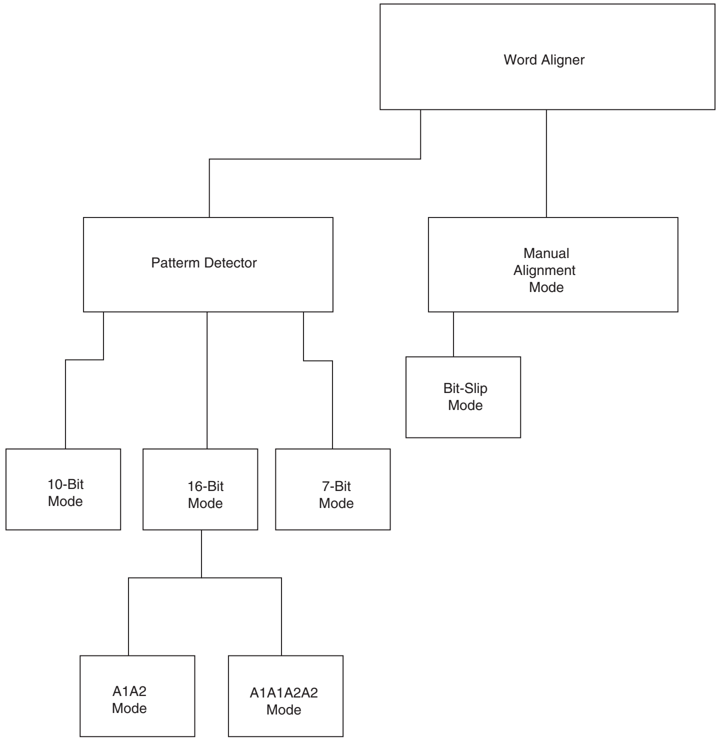
Table 1–4. Stratix GX Device Speed Grades

Device	672-Pin FineLine BGA	1,020-pin FineLine BGA
EP1SGX10	-5, -6, -7	
EP1SGX25	-5, -6, -7	-5, -6, -7
EP1SGX40		-5, -6, -7

High-Speed I/O Interface Functional Description

The Stratix GX device family supports high-speed serial transceiver blocks with CDR circuitry as well as source-synchronous interfaces. The channels on the right side of the device use an embedded circuit dedicated for receiving and transmitting high-speed serial data streams to and from the system board. These channels are clustered in a four-channel serial transceiver building block and deliver high-speed bidirectional point-to-point data transmissions to provide up to 3.1875 Gbps of full-duplex data transmission per channel. The channels on the left side of the device support source-synchronous data transfers at up to 1 Gbps using LVDS, LVPECL, 3.3-V PCML, or HyperTransport technology I/O standards. Figure 1–1 shows the Stratix GX I/O blocks. The differential source-synchronous serial interface and the high-speed serial interface are described in the *Stratix GX Transceivers* chapter of the *Stratix GX Device Handbook, Volume 1*.

Figure 2–15. Word Aligner in Bit-Slip Mode



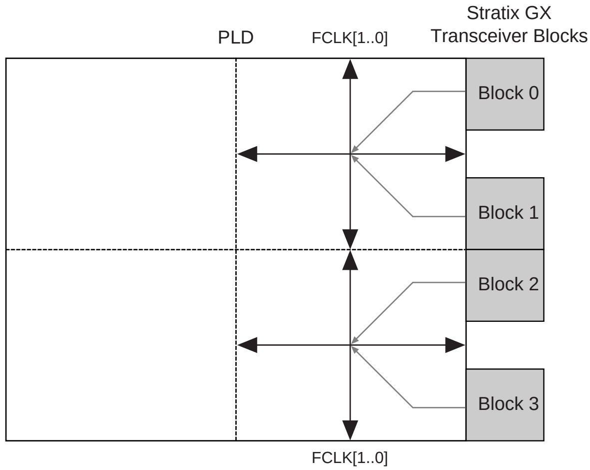
In the bit-slip mode, the byte boundary can be modified by a barrel shifter to slip the byte boundary one bit at a time via a user-controlled bit-slip port. The bit-slip mode supports both 8-bit and 10-bit data paths operating in a single or double-width mode.

The pattern detector is active in the bit-slip mode, and it detects the user-defined pattern that is specified in the MegaWizard® Plug-In Manager.

The bit-slip mode is available only in Custom mode and SONET mode.

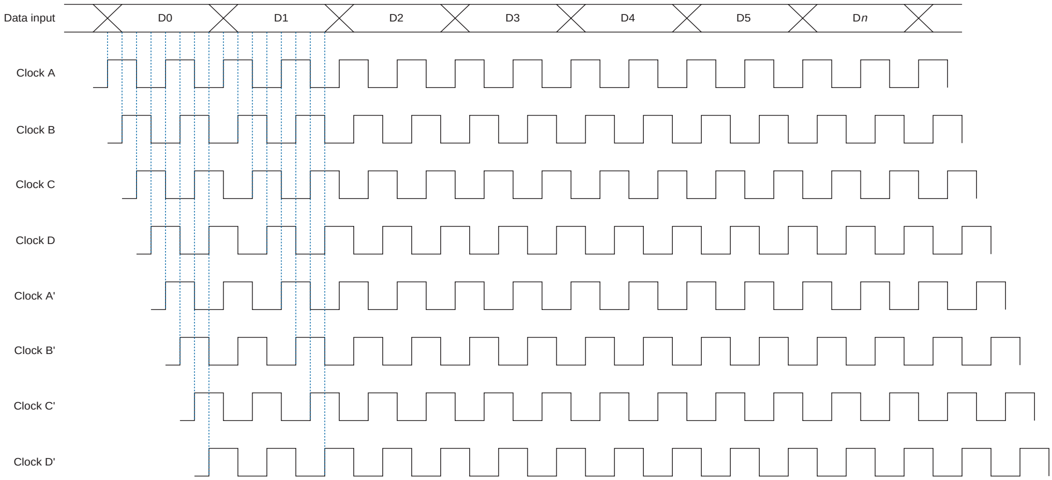
Figure 2–16 shows the word aligner in 16-bit mode.

Figure 2–29. EP1SGX25 Receiver PLL Recovered Clock to Fast Regional Clock Connection



In the EP1SGX40 device, the receiver PLL recovered clocks from transceivers 0 and 1 drive `RCLK[1..0]` while transceivers 2, 3, and 4 drive `RCLK[7..6]`. The regional clocks feed logic in their associated regions.

Figure 3–9. Fast PLL Clocks & Data Input



Protocols, Training Pattern & DPA Lock Time

The dynamic phase aligner uses a fast PLL for clock multiplication, and the dynamic phase selector for the phase detection and alignment. The dynamic phase aligner uses the high-speed clock out of the dynamic phase selector to deserialize high-speed data and the receiver's source synchronous operations.

At each rising edge of the clock, the dynamic phase selector determines the phase difference between the clock and the data and automatically compensates for the phase difference between the data and clock.

Dynamic Arithmetic Mode

The dynamic arithmetic mode is ideal for implementing adders, counters, accumulators, wide parity functions, and comparators. An LE in dynamic arithmetic mode uses four 2-input LUTs configurable as a dynamic adder/subtractor. The first two 2-input LUTs compute two summations based on a possible carry-in of 1 or 0; the other two LUTs generate carry outputs for the two chains of the carry select circuitry. As shown in Figure 4–6, the LAB carry-in signal selects either the `carry-in0` or `carry-in1` chain. The selected chain's logic level in turn determines which parallel sum is generated as a combinatorial or registered output. For example, when implementing an adder, the sum output is the selection of two possible calculated sums: `data1` + `data2` + `carry-in0` or `data1` + `data2` + `carry-in1`. The other two LUTs use the `data1` and `data2` signals to generate two possible carry-out signals—one for a carry of 1 and the other for a carry of 0. The `carry-in0` signal acts as the carry select for the `carry-out0` output and `carry-in1` acts as the carry select for the `carry-out1` output. LEs in arithmetic mode can drive out registered and unregistered versions of the LUT output.

The dynamic arithmetic mode also offers clock enable, counter enable, synchronous up/down control, synchronous clear, synchronous load, and dynamic adder/subtractor options. The LAB local interconnect data inputs generate the counter enable and synchronous up/down control signals. The synchronous clear and synchronous load options are LAB-wide signals that affect all registers in the LAB. The Quartus II software automatically places any registers that are not used by the counter into other LABs. The `addnsub` LAB-wide signal controls whether the LE acts as an adder or subtractor.

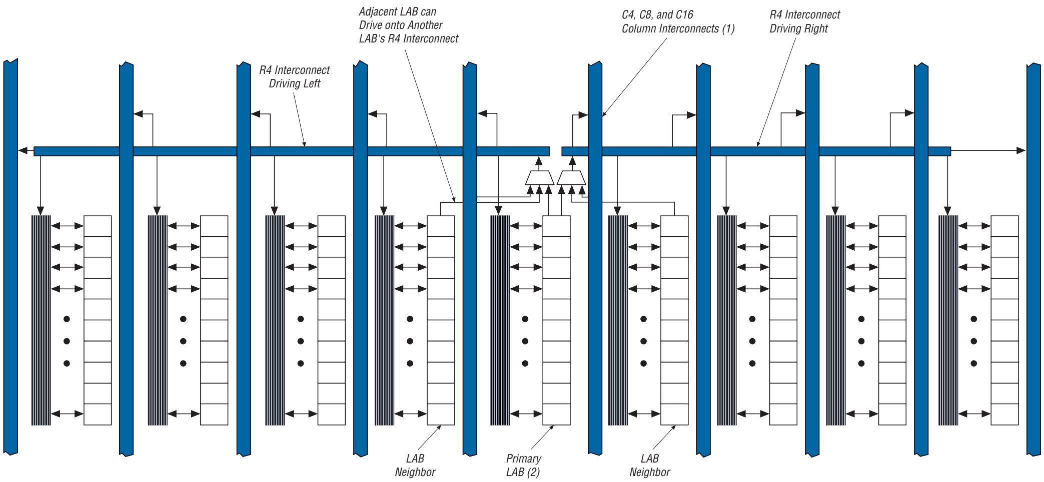
for accumulator functions. Another portion of the LUT generates carry-out bits. An LAB-wide carry in bit selects which chain to use for the addition of given inputs. The carry-in signal for each chain, `carry-in0` or `carry-in1`, selects the carry-out to carry forward to the carry-in signal of the next-higher-order bit. The final carry-out signal is routed to an LE, where it is fed to local, row, or column interconnects.

The Quartus II Compiler automatically creates carry chain logic during design processing, or you can create it manually during design entry. Parameterized functions such as LPM functions automatically take advantage of carry chains for the appropriate functions.

The Quartus II Compiler creates carry chains longer than 10 LEs by linking LABs together automatically. For enhanced fitting, a long carry chain runs vertically allowing fast horizontal connections to TriMatrix™ memory and DSP blocks. A carry chain can continue as far as a full column.

can drive on to the interconnect. R4 interconnects can drive other R4 interconnects to extend the range of LABs they can drive. R4 interconnects can also drive C4 and C16 interconnects for connections from one row to another. Additionally, R4 interconnects can drive R24 interconnects.

Figure 4–8. R4 Interconnect Connections



Notes to Figure 4–8:

(1) C4 interconnects can drive R4 interconnects.

(2) This pattern is repeated for every LAB in the LAB row.

The R8 interconnects span eight LABs, M512 or M4K RAM blocks, or DSP blocks to the right or left from a source LAB. These resources are used for fast row connections in an eight-LAB region. Every LAB has its own set of R8 interconnects to drive either left or right. R8 interconnect connections between LABs in a row are similar to the R4 connections shown in Figure 4–8, with the exception that they connect to eight LABs to the right or left, not four. Like R4 interconnects, R8 interconnects can drive and be driven by all types of architecture blocks. R8 interconnects can drive other R8 interconnects to extend their range as well as C8 interconnects for row-to-row connections. One R8 interconnect is faster than two R4 interconnects connected together.

R24 row interconnects span 24 LABs and provide the fastest resource for long row connections between LABs, TriMatrix memory, DSP blocks, and IOEs. The R24 row interconnects can cross M-RAM blocks. R24 row interconnects drive to other row or column interconnects at every fourth single block of RAM ideal for data packet storage. The different-sized blocks allow Stratix GX devices to efficiently support variable-sized memory in designs.

The Quartus II software automatically partitions the user-defined memory into the embedded memory blocks using the most efficient size combinations. You can also manually assign the memory to a specific block size or a mixture of block sizes.

M512 RAM Block

The M512 RAM block is a simple dual-port memory block and is useful for implementing small FIFO buffers, DSP, and clock domain transfer applications. Each block contains 576 RAM bits (including parity bits). M512 RAM blocks can be configured in the following modes:

- Simple dual-port RAM
- Single-port RAM
- FIFO
- ROM
- Shift register

When configured as RAM or ROM, you can use an initialization file to pre-load the memory contents.

The memory address depths and output widths can be configured as 512 × 1, 256 × 2, 128 × 4, 64 × 8 (64 × 9 bits with parity), and 32 × 16 (32 × 18 bits with parity). Mixed-width configurations are also possible, allowing different read and write widths. Table 4–3 summarizes the possible M512 RAM block configurations.

Table 4–3. M512 RAM Block Configurations (Simple Dual-Port RAM)

Read Port	Write Port						
	512 × 1	256 × 2	128 × 4	64 × 8	32 × 16	64 × 9	32 × 18
512 × 1	✓	✓	✓	✓	✓		
256 × 2	✓	✓	✓	✓	✓		
128 × 4	✓	✓	✓		✓		
64 × 8	✓	✓		✓			
32 × 16	✓	✓	✓		✓		
64 × 9						✓	
32 × 18							✓

The memory address depths and output widths can be configured as 4,096 × 1, 2,048 × 2, 1,024 × 4, 512 × 8 (or 512 × 9 bits), 256 × 16 (or 256 × 18 bits), and 128 × 32 (or 128 × 36 bits). The 128 × 32- or 36-bit configuration is not available in the true dual-port mode. Mixed-width configurations are also possible, allowing different read and write widths. Tables 4–4 and 4–5 summarize the possible M4K RAM block configurations.

Table 4–4. M4K RAM Block Configurations (Simple Dual-Port)

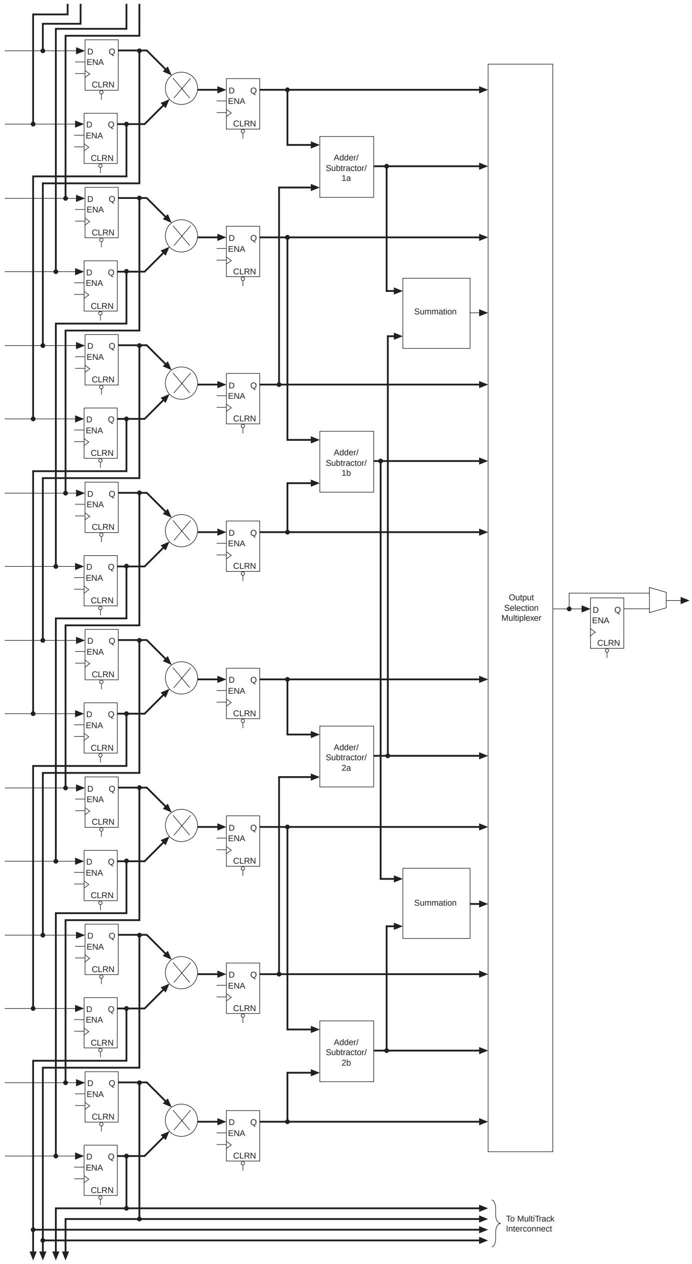
Read Port	Write Port								
	4K 1	2K × 2	1K ° 4	512 ° 8	256 ° 16	128 ° 32	512 ° 9	256 ° 18	128 ° 36
4K × 1	✓	✓	✓	✓	✓	✓			
2K × 2	✓	✓	✓	✓	✓	✓			
1K × 4	✓	✓	✓	✓	✓	✓			
512 × 8	✓	✓	✓	✓	✓	✓			
256 × 16	✓	✓	✓	✓	✓	✓			
128 × 32	✓	✓	✓	✓	✓	✓			
512 × 9							✓	✓	✓
256 × 18							✓	✓	✓
128 × 36							✓	✓	✓

Table 4–5. M4K RAM Block Configurations (True Dual-Port)

Port A	Port B						
	4K × 1	2K × 2	1K × 4	512 × 8	256 × 16	512 × 9	256 × 18
4K × 1	✓	✓	✓	✓	✓		
2K × 2	✓	✓	✓	✓	✓		
1K × 4	✓	✓	✓	✓	✓		
512 × 8	✓	✓	✓	✓	✓		
256 × 16	✓	✓	✓	✓	✓		
512 × 9						✓	✓
256 × 18						✓	✓

When the M4K RAM block is configured as a shift register block, you can create a shift register up to 4,608 bits ($w \times m \times n$).

Figure 4–30. DSP Block Diagram for 9 × 9-Bit Configuration



These clocks are organized into a hierarchical clock structure that allows for up to 22 clocks per device region with low skew and delay. This hierarchical clocking scheme provides up to 40 unique clock domains within EP1SGX10 and EP1SGX25 devices, and 48 unique clock domains within EP1SGX40 devices.

There are 12 dedicated clock pins (`CLK[15..12]`, and `CLK[7..0]`) to drive either the global or regional clock networks. Three clock pins drive the top, bottom, and left side of the device. Enhanced and fast PLL outputs as well as an I/O interface can also drive these global and regional clock networks.

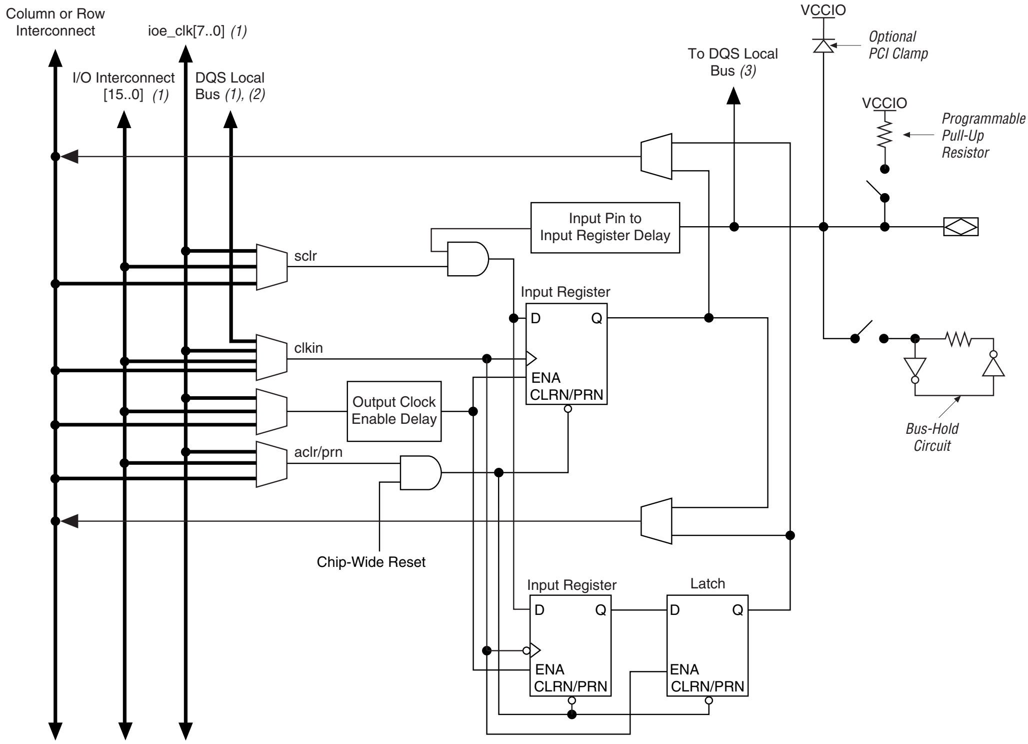
There are up to 20 recovered clocks (`rxclkout[20..0]`) and up to 5 transmitter clock outputs (`coreclk_out`) which can drive any of the global clock networks (`CLK[15..0]`), as shown in Figure 4–41.

Global Clock Network

These clocks drive throughout the entire device, feeding all device quadrants. The global clock networks can be used as clock sources for all resources within the device IOEs, LEs, DSP blocks, and all memory blocks. These resources can also be used for control signals, such as clock enables and synchronous or asynchronous clears fed from the external pin. The global clock networks can also be driven by internal logic for internally generated global clocks and asynchronous clears, clock enables, or other control signals with large fanout. Figure 4–41 shows the 12 dedicated `CLK` pins and the transceiver clocks driving global clock networks.

When using the IOE for DDR inputs, the two input registers clock double rate input data on alternating edges. An input latch is also used within the IOE for DDR input acquisition. The latch holds the data that is present during the clock high times. This allows both bits of data to be synchronous with the same clock edge (either rising or falling). Figure 4–64 shows an IOE configured for DDR input. Figure 4–65 shows the DDR input timing diagram.

Figure 4–64. Stratix GX IOE in DDR Input I/O Configuration *Note (1)*



Notes to Figure 4–64:

(1) All input signals to the IOE can be inverted at the IOE.
(2) This signal connection is only allowed on dedicated DQ function pins.
(3) This signal is for dedicated DQS function pins only.

The bus-hold circuitry uses a resistor with a nominal resistance (R_{BH}) of approximately 7 kΩ to weakly pull the signal level to the last-driven state. The chapter *DC & Switching Characteristics* of the *Stratix GX Device Handbook, Volume 1* gives the specific sustaining current driven through this resistor and the overdrive current used to identify the next-driven input level. This information is provided for each V_{CCIO} voltage level.

The bus-hold circuitry is active only after configuration. When going into user mode, the bus-hold circuit captures the value on the pin present at the end of configuration.

Programmable Pull-Up Resistor

Each Stratix GX device I/O pin provides an optional programmable pull-up resistor during user mode. If this feature is enabled for an I/O pin, the pull-up resistor (typically 25 kΩ) weakly holds the output to the V_{CCIO} level of the output pin's bank. Table 4–26 shows which pin types support the weak pull-up resistor feature.

Table 4–26. Programmable Weak Pull-Up Resistor Support

Pin Type	Programmable Weak Pull-Up Resistor
I/O pins	✓
`CLK[15..0]`	
`FCLK`	✓
`FPLL[7..10]CLK`	
Configuration pins	
JTAG pins	✓ *(1)*

Note to Table 4–26:
(1) TDO pins do not support programmable weak pull-up resistors.

Advanced I/O Standard Support

Stratix GX device IOEs support the following I/O standards:

- LVTTL
- LVCMOS
- 1.5 V
- 1.8 V
- 2.5 V
- 3.3-V PCI
- 3.3-V PCI-X 1.0
- 3.3-V AGP (1× and 2×)

However, there is additional resistance present between the device ball and the input of the receiver buffer, as shown in Figure 4–71. This resistance is because of package trace resistance (which can be calculated as the resistance from the package ball to the pad) and the parasitic layout metal routing resistance (which is shown between the pad and the intersection of the on-chip termination and input buffer).

Figure 4–71. Differential Resistance of LVDS Differential Pin Pair (R_D)

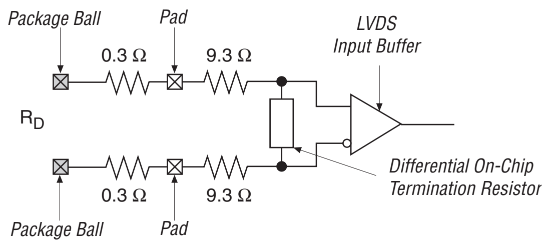


Table 4–31 defines the specification for internal termination resistance for commercial devices.

Table 4–31. Differential On-Chip Termination

Symbol	Description	Conditions	Resistance			Unit
			Min	Typ	Max	
R_D *(2)*	Internal differential termination for LVDS	Commercial *(1)*, *(3)*	110	135	165	Ω
		Industrial *(2)*, *(3)*	100	135	170	Ω

Notes to Table 4–31:

(1) Data measured over minimum conditions (T_j = 0 C, V_{CCIO} +5%) and maximum conditions (T_j = 85 C, V_{CCIO} = –5%).

(2) Data measured over minimum conditions (T_j = –40 C, V_{CCIO} +5%) and maximum conditions (T_j = 100 C, V_{CCIO} = –5%).

(3) LVDS data rate is supported for 840 Mbps using internal differential termination.

MultiVolt I/O Interface

The Stratix GX architecture supports the MultiVolt I/O interface feature, which allows Stratix GX devices in all packages to interface with systems of different supply voltages.

The Stratix GX `VCCINT` pins must always be connected to a 1.5-V power supply. With a 1.5-V V_{CCINT} level, input pins are 1.5-V, 1.8-V, 2.5-V, and 3.3-V tolerant. The `VCCIO` pins can be connected to either a 1.5-V, 1.8-V,

Table 4–36. Stratix GX JTAG Timing Parameters & Values (Part 2 of 2)

Symbol	Parameter	Min (ns)	Max (ns)
t_{JPH}	JTAG port hold time	45	
t_{JPCO}	JTAG port clock to output		25
t_{JPZX}	JTAG port high impedance to valid output		25
t_{JPXZ}	JTAG port valid output to high impedance		25
t_{JSSU}	Capture register setup time	20	
t_{JSH}	Capture register hold time	45	
t_{JSCO}	Update register clock to output		35
t_{JSZX}	Update register high impedance to valid output		35
t_{JSXZ}	Update register valid output to high impedance		35

and before and during configuration. Together, the configuration and initialization processes are called command mode. Normal device operation is called user mode.

A built-in weak pull-up resistor pulls all user I/O pins to V_{CCIO} before and during device configuration.

SRAM configuration elements allow Stratix GX devices to be reconfigured in-circuit by loading new configuration data into the device. With real-time reconfiguration, the device is forced into command mode with a device pin. The configuration process loads different configuration data, reinitializes the device, and resumes user-mode operation. You can perform in-field upgrades by distributing new configuration files either within the system or remotely.

Configuration Schemes

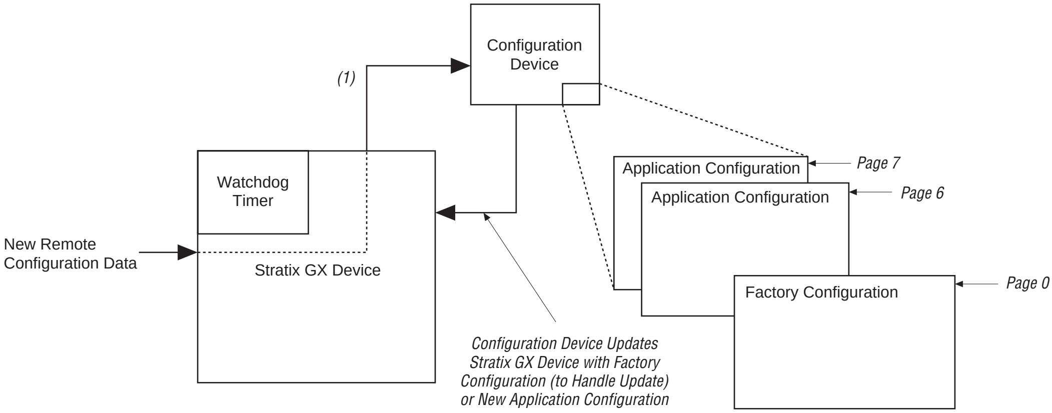
You can load the configuration data for a Stratix GX device with one of five configuration schemes (see Table 5–1), chosen on the basis of the target application. You can use a configuration device, intelligent controller, or the JTAG port to configure a Stratix GX device. A configuration device can automatically configure a Stratix GX device at system power-up.

You can configure multiple Stratix GX devices in any of five configuration schemes by connecting the configuration enable (`nCE`) and configuration enable output (`nCEO`) pins on each device.

Table 5–1. Data Sources for Configuration

Configuration Scheme	Data Source
Configuration device	Enhanced or EPC2 configuration device
Passive serial (PS)	ByteBlasterMV™ or MasterBlaster™ download cable or serial data source
Passive parallel asynchronous (PPA)	Parallel data source
Fast passive parallel	Parallel data source
JTAG	MasterBlaster or ByteBlasterMV download cable or a microprocessor with a Jam or JBC file (.jam or .jbc)

Figure 5–1. Stratix GX Device Remote Update



Note to Figure 5–1:

(1) When the Stratix GX device is configured with the factory configuration, it can handle update data from EPC16, EPC8, or EPC4 configuration device pages and point to the next page in the configuration device.

Table 6–71. EP1SGX40 Row Pin Global Clock External I/O Timing Parameters (Part 2 of 2)							
Symbol	-5 Speed Grade		-6 Speed Grade		-7 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
t_{OUTCO}	2.000	5.365	2.000	5.775	2.000	6.621	ns
$t_{INSUPLL}$	1.126		1.186		1.352		ns
t_{INHPLL}	0.000		0.000		0.000		ns
$t_{OUTCOPLL}$	0.500	2.304	0.500	2.427	0.500	2.765	ns

External I/O Delay Parameters

External I/O delay timing parameters, both for I/O standard input and output adders and programmable input and output delays, are specified by speed grade, independent of device density.

Tables 6–72 through 6–77 show the adder delays associated with column and row I/O pins. If an I/O standard is selected other than LVTTL 24 mA with a fast slew rate, add the selected delay to the external t_{CO} and t_{SU} I/O parameters.

Table 6–72. Stratix GX I/O Standard Column Pin Input Delay Adders (Part 1 of 2)							
I/O Standard	-5 Speed Grade		-6 Speed Grade		-7 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
LVCMOS		0		0		0	ps
3.3-V LVTTL		0		0		0	ps
2.5-V LVTTL		30		31		35	ps
1.8-V LVTTL		150		157		180	ps
1.5-V LVTTL		210		220		252	ps
GTL		220		231		265	ps
GTL+		220		231		265	ps
3.3-V PCI		0		0		0	ps
3.3-V PCI-X 1.0		0		0		0	ps
Compact PCI		0		0		0	ps
AGP 1×		0		0		0	ps
AGP 2×		0		0		0	ps
CTT		120		126		144	ps
SSTL-3 class I		–30		–32		–37	ps
SSTL-3 class II		–30		–32		–37	ps

7. Reference & Ordering Information

SGX51007-1.0

Software

Stratix® GX devices are supported by the Altera® Quartus® II design software, which provides a comprehensive environment for system-on-a-programmable-chip (SOPC) design. The Quartus II software includes hardware description language and schematic design entry, compilation and logic synthesis, full simulation and advanced timing analysis, SignalTap® logic analysis, and device configuration. See the *Design Software Selector Guide* for more details on the Quartus II software features.

The Quartus II software supports the Windows 2000/NT/98, Sun Solaris, Linux Red Hat v6.2 and HP-UX operating systems. It also supports seamless integration with industry-leading EDA tools through the NativeLink® interface.

Device Pin-Outs

Device pin-outs for Stratix GX devices will be released on the Altera web site (**www.altera.com**).

Ordering Information

Figure 7–1 describes the ordering codes for Stratix GX devices.

Figure 7–1. Stratix GX Device Packaging Ordering Information